

# Silicon Carbide (SiC) MOSFET – EliteSiC, 20 mohm, 1200 V, M1, Die

# NTC020N120SC1

#### Description

Silicon Carbide (SiC) MOSFET uses a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operation frequency, increased power density, reduced EMI, and reduced system size.

#### **Features**

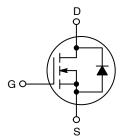
- 1200 V @  $T_J = 175$ °C
- Typ  $R_{DS(on)} = 20 \text{ m}\Omega$  at  $V_{GS} = 20 \text{ V}$ ,  $I_D = 60 \text{ A}$
- High Speed Switching with Low Capacitance
- 100% UIL Tested
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb–Free 2LI (on second level interconnection)

#### **Applications**

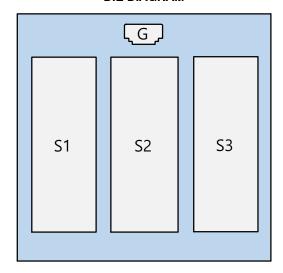
- Industrial Motor Drive
- UPS
- Boost Inverter
- PV Charger

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
1200 V	28 mΩ @ 20 V	103 A	

#### **N-CHANNEL MOSFET**



#### **DIE DIAGRAM**



# Die Information

Waler Diameter	o men	
Die Size	e Size 4,300 x 6,300 μm	
<ul> <li>Metallization</li> </ul>		
· Top · Back	Ti/TiN/Al Ti/NiV/Ag	5 μm
<ul> <li>Die Thickness</li> </ul>	Typ. 200 μm	
Gate Pad Size	600 x 310 μm	

6 inch

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 7 of this data sheet.

# **Die Cross Section Die Layout** 4300 Source Source Passivation (Polyimide) N- Epic **S**1 S2 **S**3 4519 6300 N+ Substrate 1158.5 1102

# **Passivation Information**

- Passivation Material: Polymide (PSPI)
- Passivation Type: Local Passivation
- Passivation Thickness 10  $\mu m$ 
  - : Passivation Area

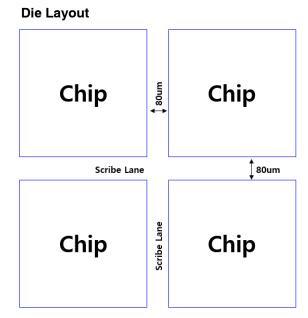


Figure 1. Bare Die Dimensions

#### MAXIMUM RATINGS (T<sub>C</sub> = 25°C unless otherwise noted)

Parame	Symbol	Value	Unit		
Drain-to-Source Voltage	V <sub>DSS</sub>	1200	V		
Gate-to-Source Voltage			V <sub>GS</sub>	-15/+25	V
Recommended Operation Values of Gate- to-Source Voltage	T <sub>C</sub> < 175°C		$V_{GSop}$	-5/+20	V
Continuous Drain Current $R_{\theta JC}$	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	103	Α
Power Dissipation $R_{\theta JC}$			P <sub>D</sub>	535	W
Continuous Drain Current R <sub>0JC</sub>	Steady T <sub>C</sub> = 100°C State		I <sub>D</sub>	73	Α
Power Dissipation $R_{\theta JC}$			P <sub>D</sub>	267	W
Pulsed Drain Current (Note 2)	Т	T <sub>C</sub> = 25°C		412	Α
Single Pulse Surge Drain Current Capability	T <sub>C</sub> = 25°C, t <sub>p</sub>	$T_C$ = 25°C, $t_p$ = 10 μs, $R_G$ = 4.7 $\Omega$		807	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	54	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 23 A, L = 1 mH) (Note 3)			E <sub>AS</sub>	264	mJ

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Note 1)	$R_{ hetaJC}$	0.28	°C/W

The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular

Repetitive rating, limited by max junction temperature.
 E<sub>AS</sub> of 264 mJ is based on starting T<sub>J</sub> = 25°C; L = 1 mH, I<sub>AS</sub> = 23 A, V<sub>DD</sub> = 120 V, V<sub>GS</sub> = 18 V.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA	1200	_	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, referenced to 25°C	-	900	-	mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1200 V, T <sub>J</sub> = 25°C	_	-	100	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1200 V, T <sub>J</sub> = 175°C	_	-	250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = +25/-15 V, V <sub>DS</sub> = 0 V	_	-	±1	μΑ
ON CHARACTERISTICS	1			•		
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS} = V_{DS}$ , $I_D = 20 \text{ mA}$	1.8	2.7	4.3	V
Recommended Gate Voltage	V <sub>GOP</sub>		-5	-	+20	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 60 A, T <sub>J</sub> = 25°C	_	20	28	mΩ
		V <sub>GS</sub> = 20 V, I <sub>D</sub> = 60 A, T <sub>J</sub> = 150°C	_	30	-	
Forward Transconductance	9FS	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 60 A	-	28	-	S
CHARGES, CAPACITANCES & GATE	RESISTANCE			•		
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 800 V	-	2890	-	pF
Output Capacitance	C <sub>OSS</sub>	]	-	260	-	
Reverse Transfer Capacitance	C <sub>RSS</sub>	]	-	22	-	
Total Gate Charge	Q <sub>G(tot)</sub>	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V}, I_D = 80 \text{ A}$	-	203	-	nC
Threshold Gate Charge	Q <sub>G(th)</sub>	]	-	33	-	
Gate-to-Source Charge	Q <sub>GS</sub>	]	_	66	-	
Gate-to-Drain Charge	Q <sub>GD</sub>	]	_	47	-	
Gate Resistance	R <sub>G</sub>	f = 1 MHz	_	1.81	-	Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS} = -5/20 \text{ V}, V_{DS} = 800 \text{ V},$	-	25	-	ns
Rise Time	t <sub>r</sub>	$I_D = 80 \text{ A}, R_G = 2 \Omega,$ Inductive Load	-	57	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	]	-	45	_	
Fall Time	t <sub>f</sub>	]	-	11	-	
Turn-On Switching Loss	E <sub>ON</sub>	]	-	2718	_	μJ
Turn-Off Switching Loss	E <sub>OFF</sub>	]	-	326	-	
Total Switching Loss	E <sub>TOT</sub>	]	-	3040	-	
DRAIN-SOURCE DIODE CHARACTER	RISTICS					
Continuous Drain-to-Source Diode Forward Current	I <sub>SD</sub>	$V_{GS} = -5 \text{ V}$	-	_	54	Α
Pulsed Drain-to-Source Diode Forward Current (Note 2)	I <sub>SDM</sub>	V <sub>GS</sub> = -5 V	-	-	412	А
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = -5 V, I <sub>SD</sub> = 30 A	-	3.7	-	V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = -5/20 V, I <sub>SD</sub> = 80 A,	-	31	-	ns
Reverse Recovery Charge	Q <sub>RR</sub>	dl <sub>S</sub> /dt = 1000 A/μs	-	240	-	nC
Reverse Recovery Energy	E <sub>REC</sub>	]	-	10	-	μJ
Peak Reverse Recovery Current	I <sub>RRM</sub>	1 1	_	15	_	Α

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

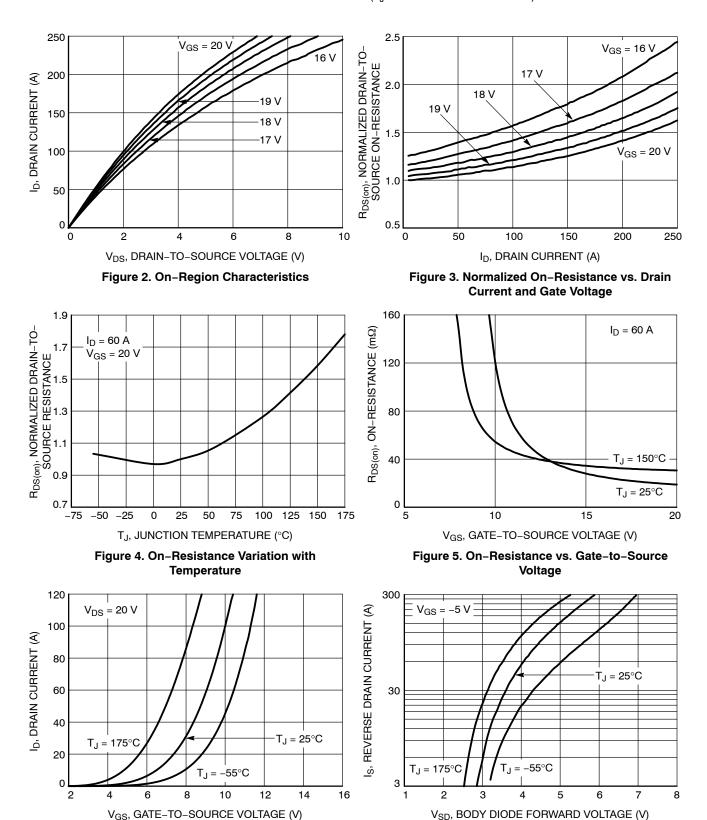


Figure 7. Diode Forward Voltage vs. Current

Figure 6. Transfer Characteristics

#### TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

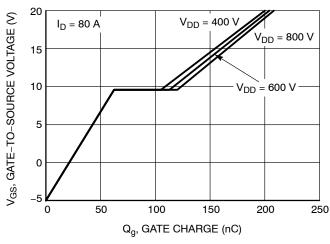


Figure 8. Gate-to-Source Voltage vs. Total Charge

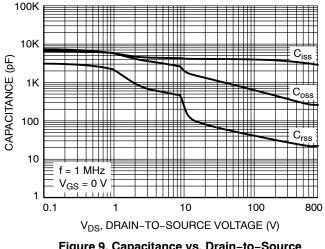


Figure 9. Capacitance vs. Drain-to-Source Voltage

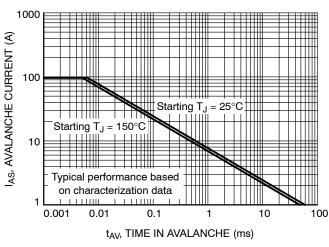


Figure 10. Unclamped Inductive Switching Capability

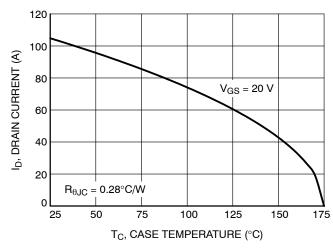


Figure 11. Maximum Continuous Drain Current vs. Case Temperature

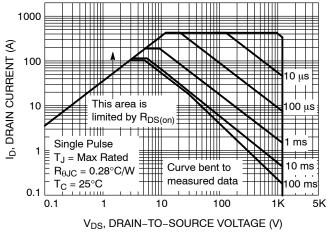


Figure 12. Safe Operating Area

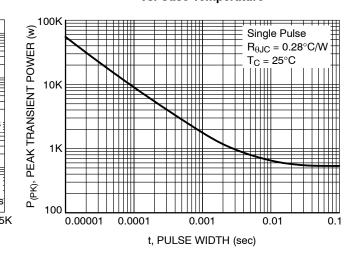


Figure 13. Single Pulse Maximum Power Dissipation

# $\textbf{TYPICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted) \ (continued)$

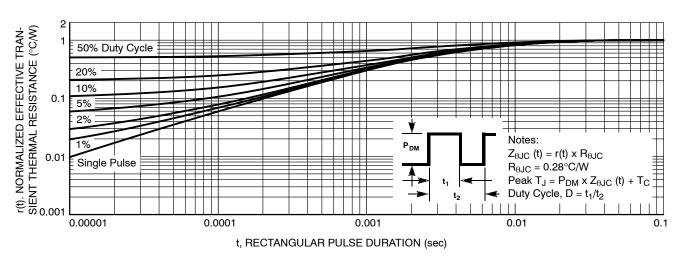


Figure 14. Junction-to-Ambient Thermal Response

#### ORDERING INFORMATION AND PACKAGE MARKING

Part Number	Part Number Top Marking		Package Packing Method	Reel Size	Tape Width	Quantity	
NTC020N120SC1	N/A	Die	Wafer	N/A	N/A	N/A	

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